

<b>Notice of References Cited</b>	Application/Control No. 10/556,453	Applicant(s)/Patent Under Reexamination LEE ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0178310 A1	11-2002	Nozaki, Akihiro	710/240
*	B	US-2003/0084212 A1	05-2003	Butterfield, David A.	710/22
*	C	US-6,266,715 B1	07-2001	Loyer et al.	710/22
*	D	US-2002/0062408 A1	05-2002	Jahnke et al.	710/22
*	E	US-2003/0172224 A1	09-2003	Gulick et al.	711/1
*	F	US-6,742,076 B2	05-2004	Wang et al.	710/314
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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